

# **Notice of References Cited**

Application/Control No.

09/437,496

Applicant(s)/Patent Under  
Reexamination  
INOUE ET AL.

Examiner

Phuoc H. Nguyen

Art Unit

2143

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## **U.S. PATENT DOCUMENTS**

* A	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
B	US-6,072,468 A	06-2000	Hocker et al.	
C	US-5,796,394	08-1998	Wicks et al.	345/157
D	US-6,137,476 A	10-2000	Hocker et al.	345/751
E	US-6,278,454 B1	08-2001	Krishnan, Shankarnarayan	345/163
F	US-6,112,244 A	08-2000	Moore et al.	345/846
G	US-5,930,472 A	07-1999	Smith, Dwight Randall	709/228
H	US-5,838,926 A	11-1998	Yamagishi, Yoichi	709/203
I	US-6,397,259 B1	05-2002	Lincke et al.	709/249
J	US-6,249,516 B1	06-2001	Brownrigg et al.	709/236
K	US-6,415,330 B1	07-2002	Okanoue, Kazuhiro	370/338
L	US-			709/245
M	US-			

## **FOREIGN PATENT DOCUMENTS**

* N	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
O					
P					
Q					
R					
S					
T					

## **NON-PATENT DOCUMENTS**

* U	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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W	
X	

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